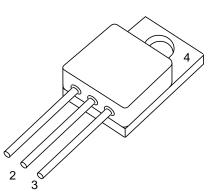


## HiRel RadHard Power-MOS

- Low R<sub>DS(on)</sub>
- Total Ionisation Dose (TID) hardened 100 kRad approved
- Hermetically sealed
- N-channel



Туре	Marking	Pin Co	nfigurati	ion		Package
		1	2	3	4	
BUY25CS45B-01	-	D	S	G	Not connected	TO-254AA

#### Maximum Ratings

Parameter	Symbol	Values	Unit
Drain Source Voltage	V <sub>DS</sub>	250	V
Gate Source Voltage	V <sub>GS</sub>	+/- 20	V
Drain Gate Voltage	V <sub>DG</sub>	250	V
Continuous Drain Current $T_c = 25 \ ^{\circ}C$ $T_c = 100 \ ^{\circ}C$	ID	45 29	A
Continuous Source Current	Is	45	А
Drain Current Pulsed, $t_p$ limited by $T_{jmax}$	I <sub>DM</sub>	180	Apk
Total Power Dissipation 1)	P <sub>tot</sub>	208	W
Junction Temperature	TJ	-55 to + 150	°C
Operating and Storage Temperature	T <sub>op</sub>	-55 to + 150	°C
Avalanche Energy	E <sub>AS</sub>	380	mJ

### **Thermal Characteristics**

Thermal Resistance (Junction to Case)	R <sub>th JC</sub>	0.6	K/W
Soldering Temperature	T <sub>sol</sub>	250	°C

#### Notes .:

1) For  $T_S \le 25^{\circ}$ C. For  $T_S > 25^{\circ}$ C derating is required.



#### Data Sheet BUY25CS45B-01

Electrical Characteristics, at T<sub>4</sub>=25°C: unless otherwise specified

Parameter	Symbol		Values	;	Unit
		min.	typ.	max.	
DC Characteristics	1		•		
Breakdown Voltage Drain to Source $I_D = 0.25 \text{mA}, V_{GS} = 0 \text{V}$	B <sub>VDSS</sub>	250	-	-	V
Gate Threshold Voltage I <sub>D</sub> = 1.0mA, V <sub>DS</sub> ≥ V <sub>GS</sub>	V <sub>GS(th)</sub>	2.0	-	4.0	V
Gate to Source Leakage Current V <sub>DS</sub> = 0V, V <sub>GS</sub> = +/- 20V	I <sub>GSS</sub>	-	-	+/-100	nA
Drain Current V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V	I <sub>DSS</sub>	-	-	25	μA
Drain Source On Resistance <sup>1)</sup> V <sub>GS</sub> = 10V, I <sub>D</sub> = 29A	r <sub>ds(on)</sub>	-	-	0.05	Ω
Source Drain Diode, Forward Voltage <sup>1), 2)</sup> $V_{GS} = 0V$ , $I_S = 45A$	V <sub>SD</sub>	-	-	1.4	V
AC Characteristics					
Turn-on Delay Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 29A, $R_G$ = 4.7 $\Omega$	t <sub>d(ON)</sub>	-	25	50	ns
Rise Time V <sub>DD</sub> = 50% V <sub>DS</sub> , I <sub>D</sub> = 29A, R <sub>G</sub> = 4.7 $\Omega$	tr	-	20	95	ns
Turn-off Delay Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 29A, $R_G$ = 4.7 $\Omega$	$t_{d(OFF)}$	-	55	80	ns
Fall Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 29A, $R_G$ = 4.7 $\Omega$	t <sub>f</sub>	-	7	75	ns
Reverse Recovery Time V <sub>DD</sub> < 50% V <sub>DS</sub> , I <sub>D</sub> = 45A	t <sub>rr</sub>	-	530	600	ns
Common Source Input Capacitance $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$	C <sub>iss</sub>	3.5	-	6.5	nF
Common Source Output Capacitance $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$	C <sub>oss</sub>	250	-	400	pF
Common Source Reverse Transfer Capacitance V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V, f = 1.0MHz	C <sub>rss</sub>	5	-	20	pF
Total Gate Charge V <sub>DD</sub> = 50% V <sub>DS</sub> , V <sub>GS</sub> = 10V, I <sub>D</sub> = 45A	Q <sub>G</sub>	-	70	100	nC

Notes.: 1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%. 2) Measured within 2.0 mm of case.



## **Electrical Characteristics**

at TA=125°C; unless otherwise specified

Parameter	Symbol	Va	lues	es Unit	
		min.	max.		
DC Characteristics					
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	V <sub>GS(th)</sub>	1.5	-	V	
Gate to Source Leakage Current $V_{DS} = 0V, V_{GS} = +/-20V$	I <sub>GSS</sub>	-	+/-200	nA	
Drain Current $V_{DS} = 200V, V_{GS} = 0V$	I <sub>DSS</sub>	-	250	μA	
Drain Source On Resistance <sup>1)</sup> $V_{GS} = 10V, I_D = 29A$	r <sub>DS(ON)</sub>	-	0.09	Ω	

Notes.: 1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.

## **Electrical Characteristics**

at T<sub>A</sub>=-55°C; unless otherwise specified

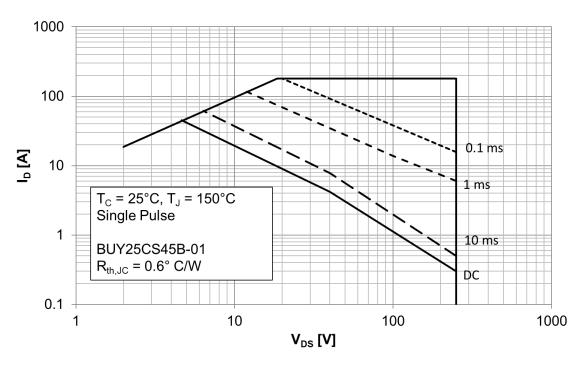
Parameter	Symbol	Values		Unit
		min.	max.	
DC Characteristics		-		
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	$V_{GS(th)}$	-	5.0	V



## Data Sheet BUY25CS45B-01

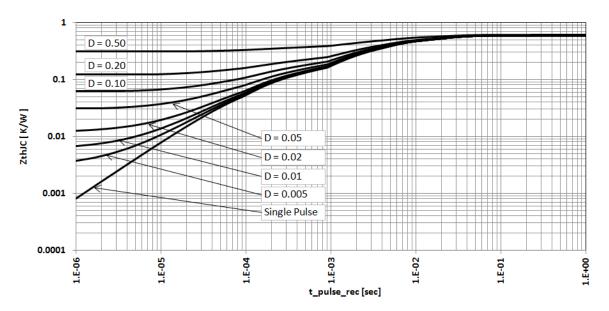
### 1 Safe operating area

 $I_D = f(V_{DS}); T_C = 25^{\circ}C$ parameter:  $t_p$ 



### 2 Max. transient thermal impedance

 $Z_{thJC} = f(t_p)$ parameter: D =  $t_p/T$ 

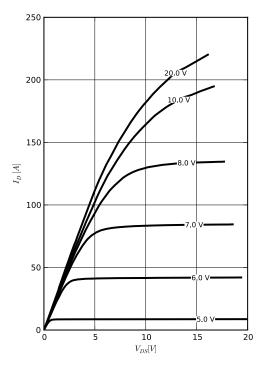




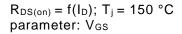
## Data Sheet

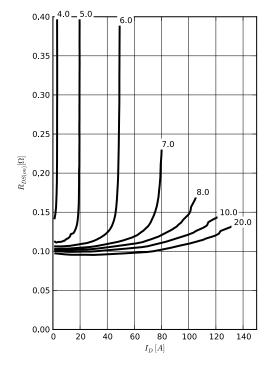
### 3 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \ ^{\circ}C$ parameter:  $V_{GS}$ 



# 5 Typ. drain-source on-state resistance

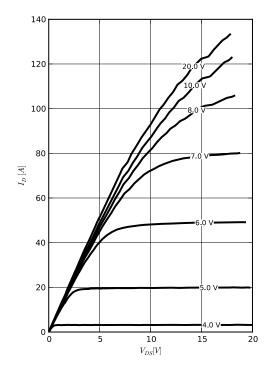




## BUY25CS45B-01

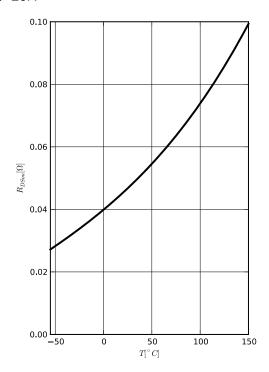
## 4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 150 \ ^{\circ}C$ parameter:  $V_G$ 



6 Typ. drain-source on-state resistance

 $\begin{array}{l} R_{DS(on)} = f(T_j) \\ I_D = 29A \end{array}$ 



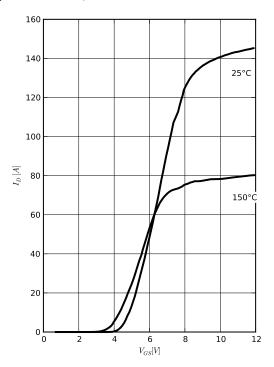


## Data Sheet

## BUY25CS45B-01

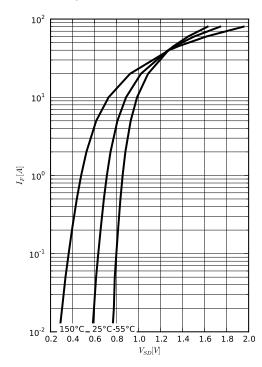
## 7 Typ. transfer characteristics

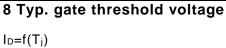
 $I_D = f(V_{GS}); |VDS| > 2 |I_D| R_{DS(on)max}$ parameter:  $T_j$ 



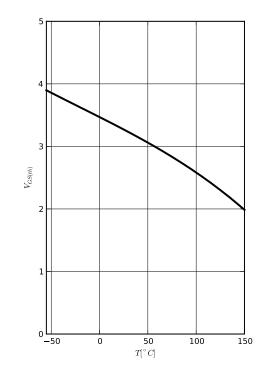
# 9 Typ. forward characteristics of reverse diode

I<sub>F</sub> = f(V<sub>SD</sub>) parameter: T<sub>j</sub>



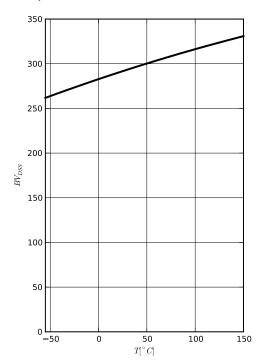


 $I_D = 1mA$ 



# 10 Typ. drain-source breakdown voltage

 $BV_{DSS} = f(T_j)$  $I_D = 250 \mu A$ 

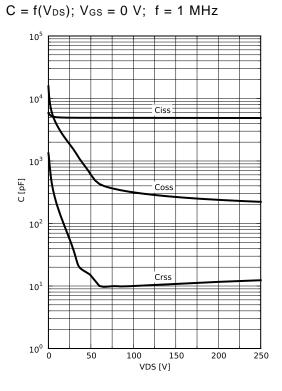




## Data Sheet

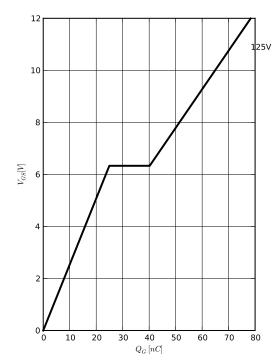
# BUY25CS45B-01

## 11 Typ. capacitances



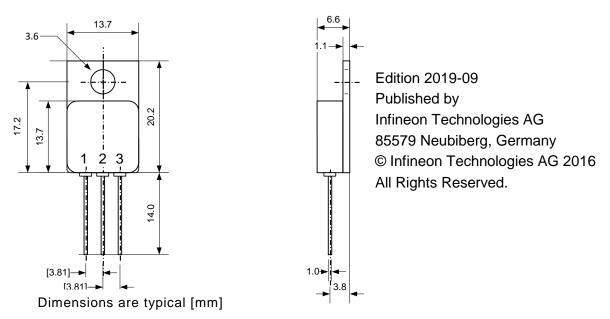
## 12 Typ. gate charge

 $V_{GS} = f(Q_{gate}); ID = 45.0 A pulsed parameter: V_{DD}$ 





## TO-254AA Package



### Caution

This package contains beryllia. Therefore it must not be in any form machined, grinded, sanded, polished or any other mechanical operation which will produce dust and particles.

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